

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant

: BEVAN et al.

Confirmation No: 5427

Appl. No.

10/633,517

Filed Title

: August 5, 2003

: ANALYTICAL METHOD AND APPARATUS THEREFOR

TC/A.U.

: 1743

Examiner

: Y. Gakh

Docket No.:

: BEVA3004D/REF

Customer No:

: 23364

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Assistant Commissioner for Patents Washington, D.C. 20231

Sir:

This Supplemental Information Disclosure Statement is being submitted in the above-identified patent application to correct an obvious error in the Country/Agency listed for reference EP 0 345 782 A in that WIPO was listed instead of EP. Also attached herewith is the Form PTO-1449 with the correct Country/Agency listed.

In addition, the present application is a divisional application and the reference cited form recently received in the parent application is submitted herewith for the convenience of the Examiner and to update the present application. In accordance with MPEP §609, a Form 1449 listing this reference is also submitted herewith. Confirmation that the corrected prior art cited above and the newly cited reference in the parent application has been considered in the next Official Action is most respectfully requested.

Respectfully submitted, BACON & THOMAS, PLLC

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December 9, 2003

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B/O Form P	TO-1449	Atty. Docket Num		Serial Number	0/000 E4		
u.s.		Applicant	A3004D/REF	1	0/633,517	/	
Pat	Department of Commerce 1885 tent and Trademark 0405	BEVAN et al.					
Information	Disclosure Statement by Applicant	Filing Date	5 2002	Group	4740	1000	
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		U.S. Pat	tent Documents		I &		
Examiner Initial	Document Number	Date	Patentee/Applicant	Class	Subclass	Filing Date if Appropriate	
	3,732,164	05/1973	Pressley et al.	210	752		
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		Foreign P	atent Documents				
						Trans	slation
Examiner Initial	Document Number	Publication Date	Country/Agency	Class	Subclass	Yes	No
	0 345 782 A	12/13/89	EP				
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	Other Documents (Including	Author, Title,	, Date, Pertinent Pages	, Place of Pub	lication, E	tc.)	
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	Other Documents (Including	Author, Title,	, Date, Pertinent Pages	, Place of Publ	lication, E	Etc.)	

Examiner Date Considered

EXAMINER: Initial if citation is considered, whether or no t citation is in conf ormance with MPEP 609; Draw a line through citation if no t in conformance and not considered. Include copy of this form with next communication to applicant.

Notic of References Cited

Application/Control No.

09/486,715

Examiner

Yelena G. Gakh, Ph.D.

Applicant(s)/Patent Under
Reexamination
BEVAN ET AL.

Art Unit
Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-3,732,164	05-1973	Pressley et al.	210/752
	В	US-			
	С	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.